


<b>Search Notes</b>  	<b>Application/Control No.</b>  10518223	<b>Applicant(s)/Patent Under Reexamination</b>  CHENG ET AL.
	<b>Examiner</b>  IQBAL H CHOWDHURY	<b>Art Unit</b>  1652

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SEARCH NOTES		
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STN and WEST Databases- updated search of 7/20/2007	8/23/08	IC

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